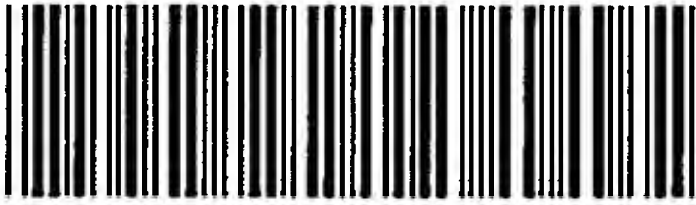


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/709,366	CHEN	
	Examiner	Art Unit	
	Steven Loke	2811	

SEARCHED			
Class	Subclass	Date	Examiner
257	665,	3/6/05	Loke
	773,		
	774,		
	776,		
	786,		
	275		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR